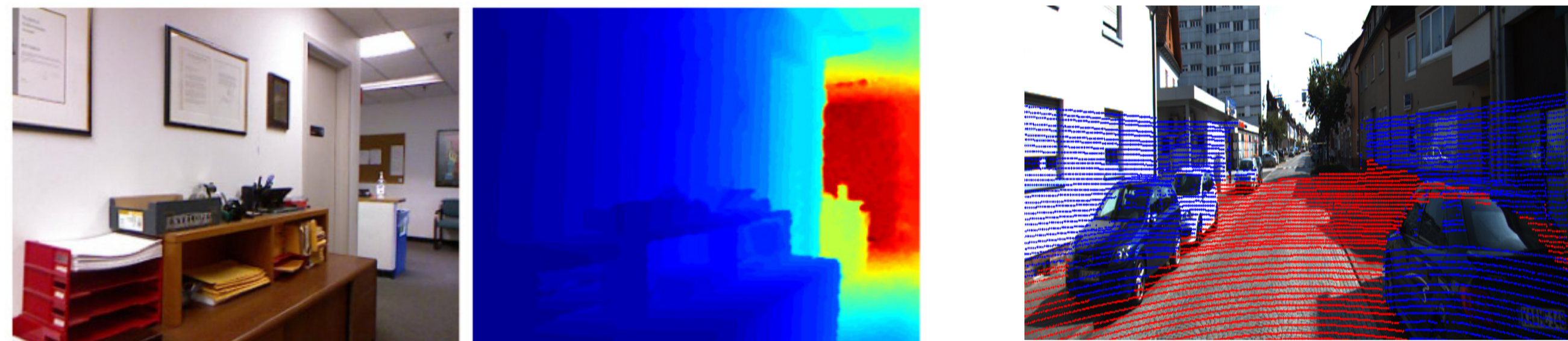


Motivation

- Problem: Fit a subspace to data contaminated with **noise** and outliers
- Prior work: Sparse & low-rank methods on low dimensional subspace
- Challenges: Many applications require subspace to be of high relative dimension; not obvious to establish guarantees in presence of noise

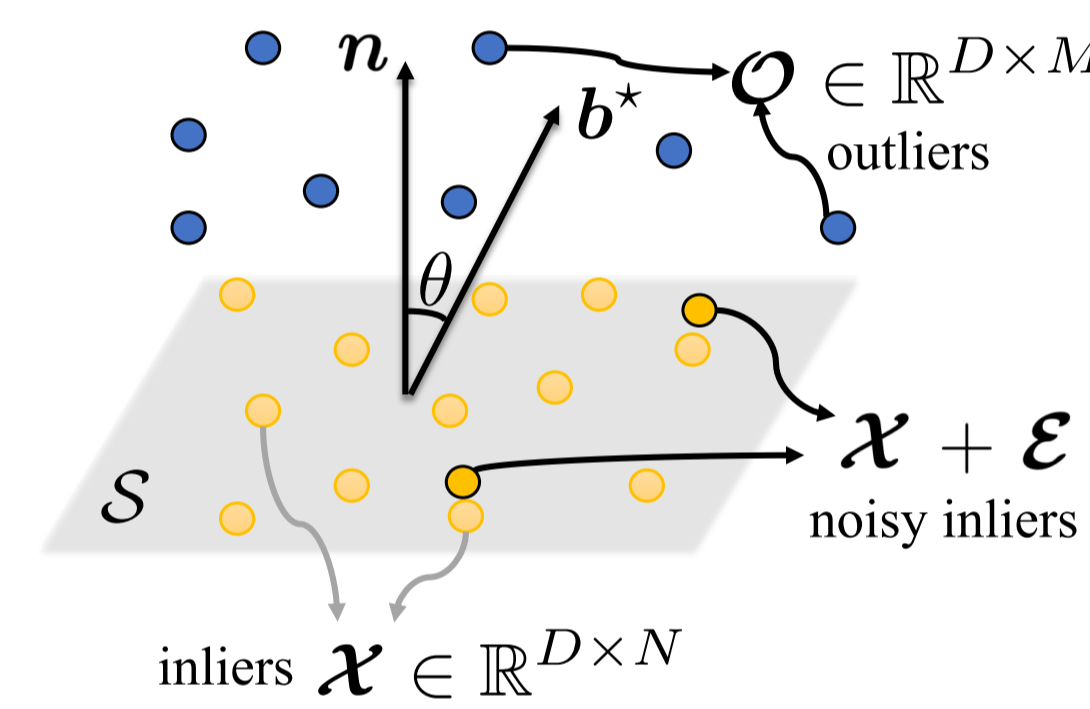


Estimating the geometry of a room from its depth map by fitting multiple planes

Estimating the road plane from points collected by a laser scanner

Dual Principal Component Pursuit (DPCP) in Noisy Setting

- Inliers \mathcal{X} span a d -dimensional subspace \mathcal{S}
- Outliers \mathcal{O} lie in ambient space \mathbb{R}^D
- Ambient noise \mathcal{E} are additive on inliers
- Given dataset $\tilde{\mathcal{X}} = [\mathcal{X} + \mathcal{E} \ \mathcal{O}]$, DPCP computes solution \mathbf{b}^* (ideally $\mathbf{b}^* \perp \mathcal{S}$) by



$$(1) \min_{\mathbf{b} \in \mathbb{S}^{D-1}: \text{unit sphere}} \|\tilde{\mathcal{X}}^T \mathbf{b}\|_1$$

- Noisy DPCP assumes $\mathcal{E} \neq \mathbf{0}$, which is opposite with the regular noiseless DPCP that based on $\mathcal{E} = \mathbf{0}$

Main Contributions

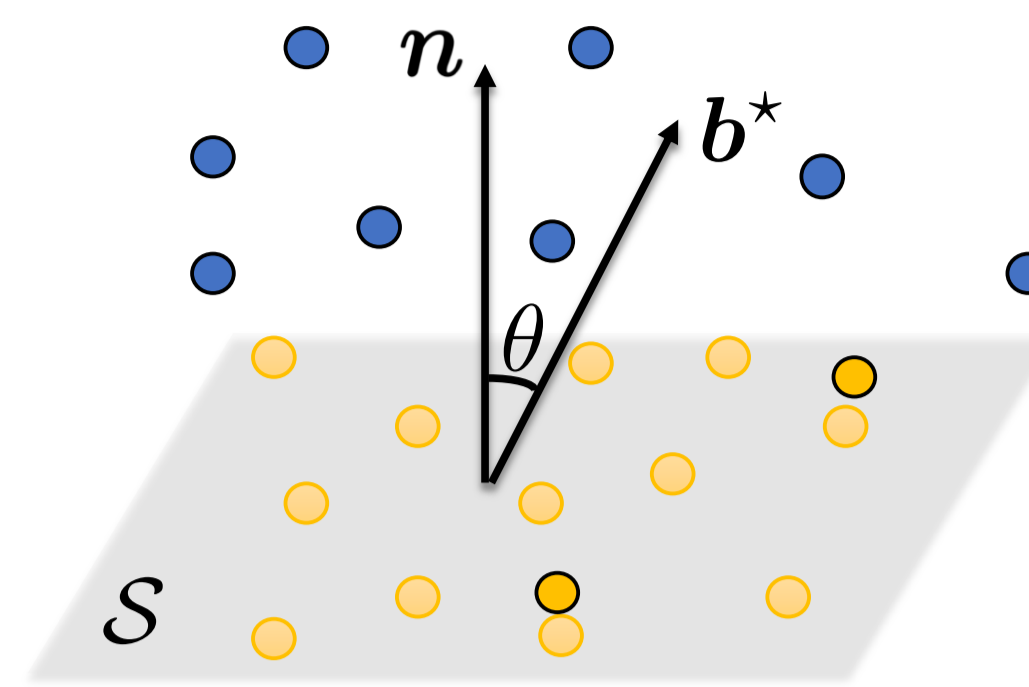
- When $\mathcal{E} = \mathbf{0}$ (noiseless), [Tsakiris & Vidal], [Zhu et al.] derived geometric conditions under which $\mathbf{b}^* \perp \mathcal{S}$ and proposed efficient algorithms
- This paper extends the global optimality and convergence theory of DPCP to the case of data corrupted by noise

Main Contributions

	Main Contributions	
Theory	Geometric Deterministic Analysis	$\text{dist}(\mathbf{b}^*, \mathcal{S}^\perp) \propto \text{noise level}$ under some conditions
	Geometric Probabilistic Analysis	$\text{dist}(\mathbf{b}^*, \mathcal{S}^\perp) \propto \text{noise level}$ with high probability if $\#\text{outliers} = O((\#\text{inliers})^2)$
Algorithm	Projected SubGradient Method (PSGM)	piecewise linear convergence: $\text{dist}(\mathbf{b}_k, \mathcal{S}^\perp) = O(\beta^k) + \text{const}$, $\beta < 1$, $\text{const} \propto \text{noise level}$

Deterministic Global Optimality Analysis

- Assume the data is given and fixed
- When $\mathcal{E} \neq \mathbf{0}$, \mathbf{b}^* will be perturbed away from \mathcal{S}^\perp by an angle θ
- $\text{dist}(\mathbf{b}^*, \mathcal{S}^\perp)$ depends on noise level



Lemma: Any critical point of (1) must have its principal angle θ satisfy:

$$\theta \leq \theta^\circ \text{ or } \theta \geq \theta^\natural,$$

where $0 \leq \theta^\circ \leq \theta^\natural \leq \pi/2$ are closely related to the two nonnegative roots of a certain quartic equation.

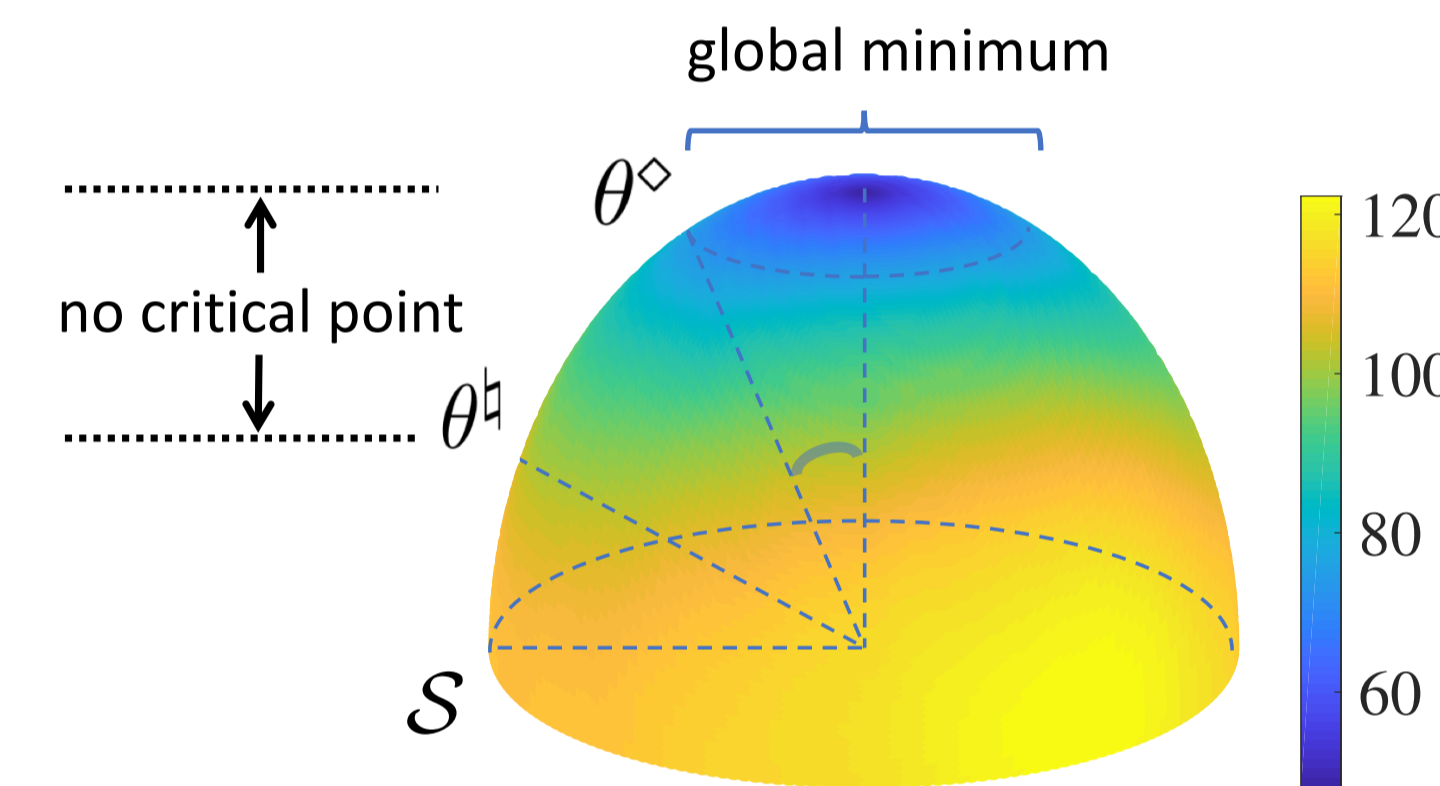
Remark: Any critical point is either close to \mathcal{S}^\perp or close to \mathcal{S}

Theorem: Any global solution \mathbf{b}^* to (1) must be close to \mathcal{S}^\perp such that $\theta \in [0, \theta^\circ]$ as long as the outlier ratio and the noise level is small.

Remark: Any global solution \mathbf{b}^* is close to \mathcal{S}^\perp such that $\theta \leq \theta^\circ$

- $\theta^\circ \propto$ the effective noise level

	θ°	θ^\natural
smaller $\ \mathcal{E}\ $	$\downarrow 0$	$\uparrow \frac{\pi}{2}$
smaller $\ \mathcal{O}\ $	$\downarrow 0$	$\uparrow \frac{\pi}{2}$



- $\mathcal{O} = \mathbf{0} \Rightarrow \theta^\natural = \pi/2$

- $\mathcal{E} = \mathbf{0} \Rightarrow \theta^\circ = 0$, which means solution \mathbf{b}^* is a normal vector of \mathcal{S}

Probabilistic Analysis

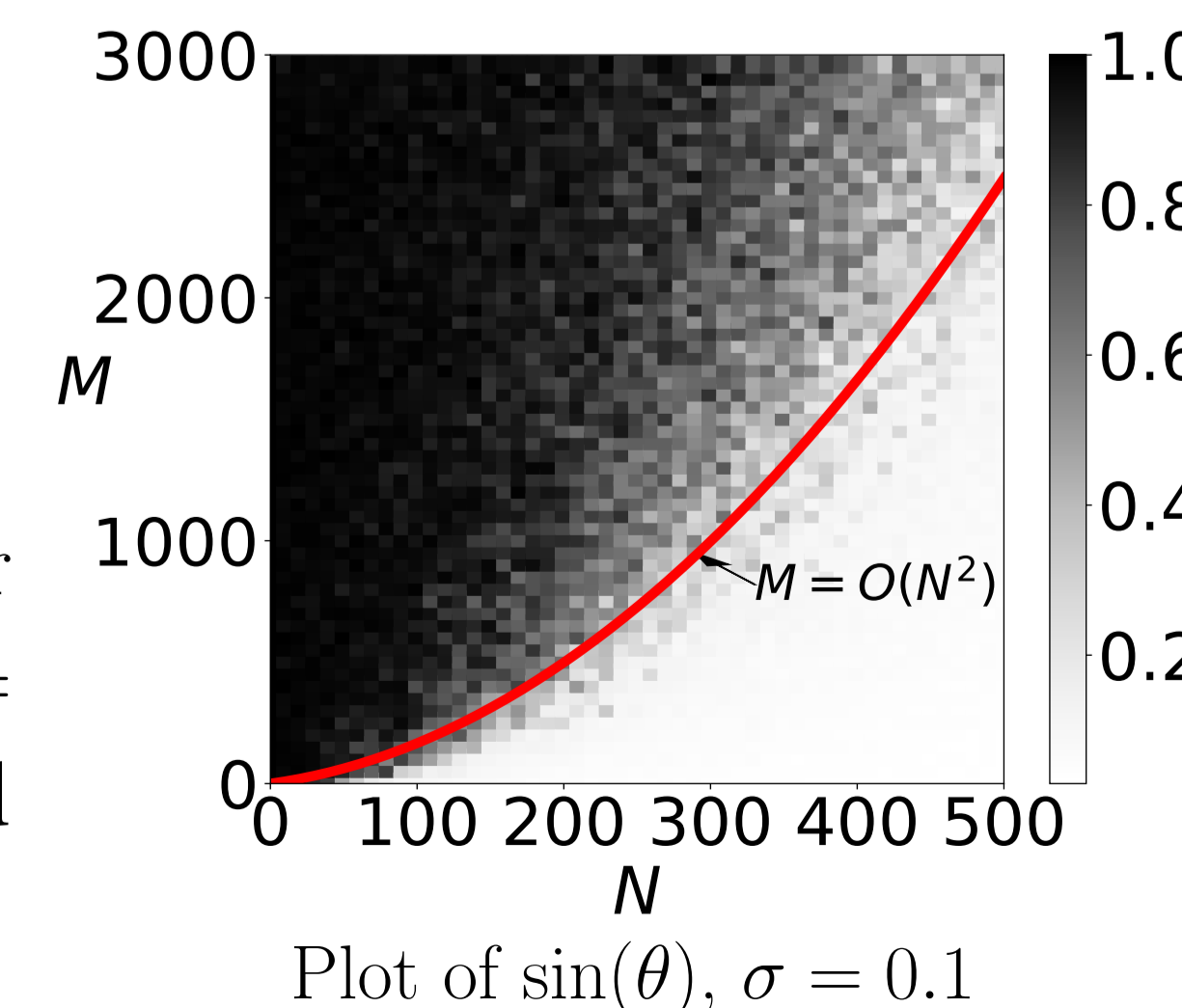
- Columns of outliers \mathcal{O} are drawn uniformly from the sphere \mathbb{S}^{D-1}
- Columns of noisy inliers $\mathcal{X} + \mathcal{E}$ are drawn from \mathbb{S}^{D-1} by normalizing i.i.d. $\mathcal{N}(\mathbf{0}, \frac{1}{d}\mathbf{I}_S + \frac{\sigma^2}{D}\mathbf{I}_D)$ -distributed points to have unit ℓ_2 norm
- Under this random model, the SNR is $\mathbb{E}[\|\mathcal{X}\|_F] / \mathbb{E}[\|\mathcal{E}\|_F] = 1/\sigma$

Theorem: Any global solution to (1) must lie in a neighborhood of \mathcal{S}^\perp such that $\sin(\theta) \lesssim \sqrt{\sigma} / (1 - \sqrt{\sigma})$ with probability exceeding $1 - O(\frac{1}{N^2})$ if $M \leq C \cdot N^2$.

- C is a constant depends on σ, D and d

	Smaller σ	Larger D, d
C	\uparrow	\downarrow

- Comparison with state-of-the-art: other methods can only handle at most $M = O(N)$ outliers in theory [Lerman and Maunu]



Projected SubGradient Method (PSGM)

Input: $\tilde{\mathcal{X}}, \{\mu_0, K_0, K\} > 0, \beta < 1$

Spectral initialization: set $\hat{\mathbf{b}}_0 \leftarrow \arg \min_{\mathbf{b} \in \mathbb{S}^{D-1}} \|\tilde{\mathcal{X}}^T \mathbf{b}\|_2$

Piecewise geometrically diminishing stepsize: $\mu_k = \mu_0 \beta^{\lfloor (k-K_0)/K \rfloor}$

PSGM update: $\mathbf{b}_{k+1} \leftarrow \hat{\mathbf{b}}_k - \mu_k \mathbf{g}_k$; \mathbf{g}_k is the sub-gradient

Projected back to sphere: $\hat{\mathbf{b}}_{k+1} \leftarrow \mathbf{b}_{k+1} / \|\mathbf{b}_{k+1}\|_2$

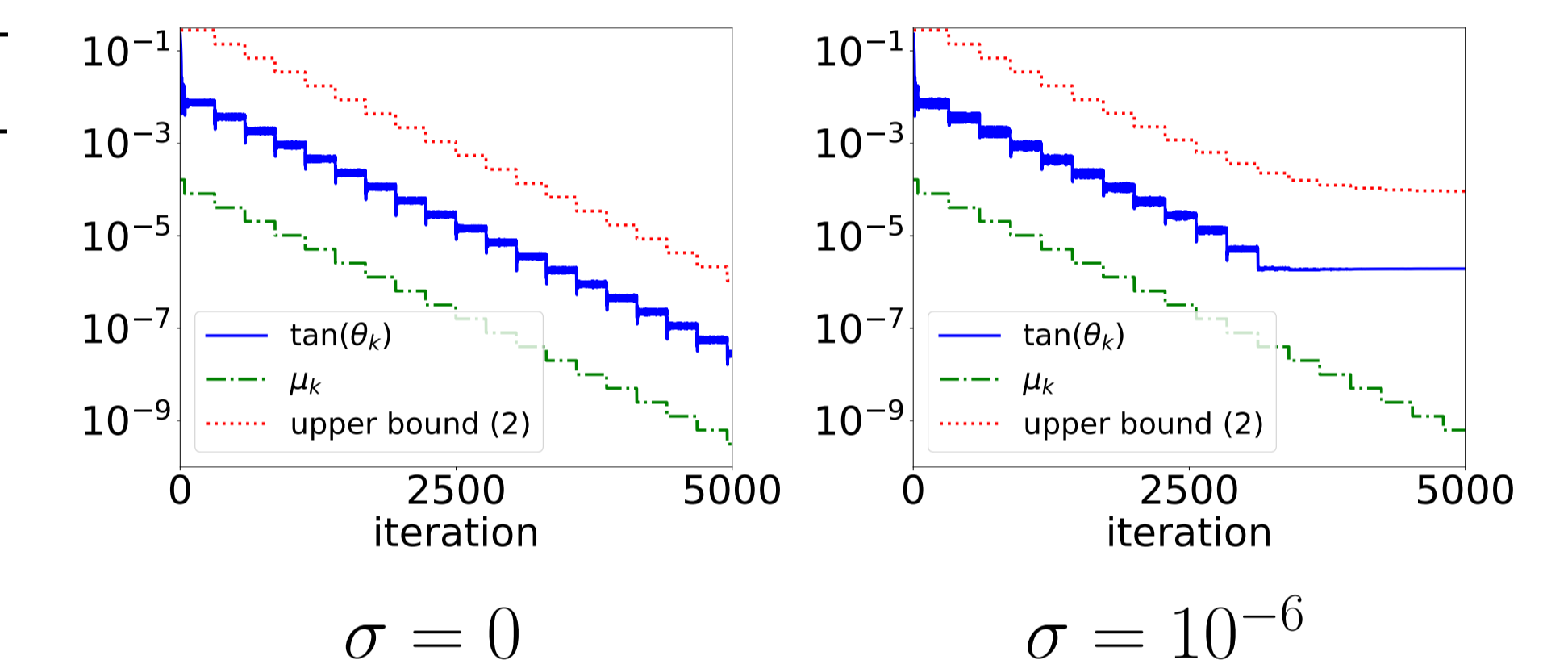
Theorem: If $\theta_0 < \theta^\natural$, $\tan(\theta_k)$ has a piecewise linear convergence rate:

$$(2) \quad \tan(\theta_k) \leq \beta^{\lfloor (k-K_0)/K \rfloor} + \tan(\theta'), \quad \forall k \geq K_0.$$

- θ' is a critical angle proportional to the effective noise level, which also depends on M, N , and the distribution of the data

$\mathcal{E} = \mathbf{0}$	M/N fixed, larger M, N , smaller noise level more well-distributed data
θ'	0

- Principal angle θ_k decays in a piecewise linear rate until θ' (noise effect); when noiseless $\theta' = 0 \Rightarrow \theta_k \rightarrow 0$

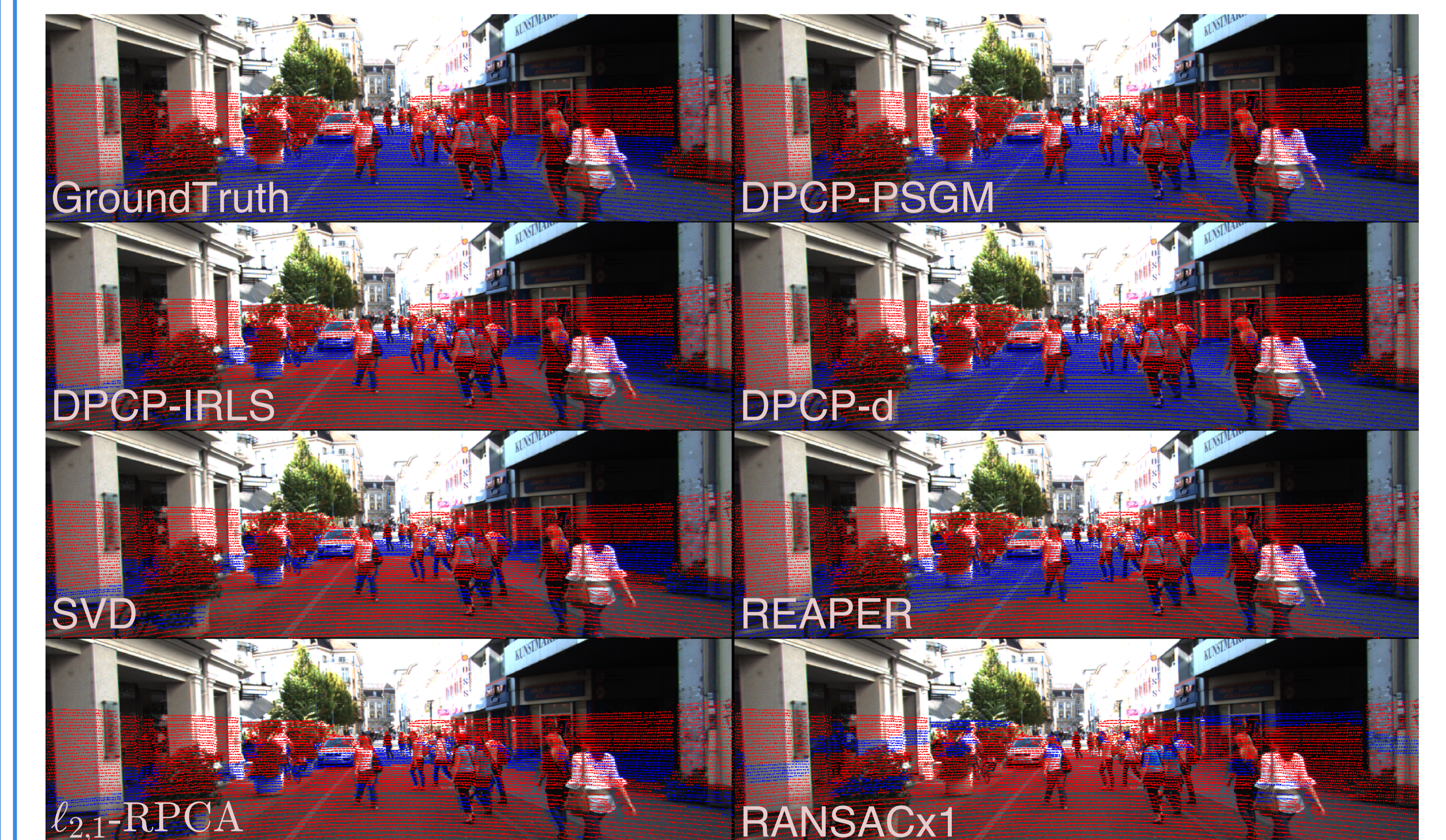


- $D = 30, d = 29, N = 1000, \frac{M}{M+N} = 0.7$

Experiments on 3D Point Cloud Road Data

Task: Given a 3D point cloud of a road scene, the goal is to learn an affine plane as a model for the road

- Determine points that lie on the plane (inliers) / off the plane (outliers)
- Frame 328 of dataset KITTI-CITY-71, with inliers (blue) / outliers (red)



Contains around 10^5 points with approximately 50% outliers